

Notice of References Cited	Application/Control No. 10/677,025	Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Fikremariam Yalew	Art Unit 2136	Page 1 of 1

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*	C	US-7,107,493	09-2006	Nguyen et al.	714/42
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NON-PATENT DOCUMENTS

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